

General Description

The GreenMOS[®] high voltage MOSFET utilizes charge balance technology to achieve outstanding low on-resistance and lower gate charge. It is engineered to minimize conduction loss, provide superior switching performance and robust avalanche capability.

The GreenMOS[®] Generic series is optimized for extreme switching performance to minimize switching loss. It is tailored for high power density applications to meet the highest efficiency standards.

Features

- Low $R_{DS(ON)}$ & FOM
- Extremely low switching loss
- Excellent stability and uniformity

GreenMOS[®]



Applications

- PC power
- LED lighting
- Telecom power
- Server power
- EV Charger
- Solar/UPS

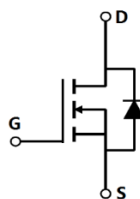
Key Performance Parameters

Parameter	Value	Unit
V_{DS}	650	V
I_D , pulse	24	A
$R_{DS(ON)}$, max @ $V_{GS}=10V$	580	m Ω
Q_g	8.9	nC
PD	8	W

Marking Information

Product Name	Package	Marking
OSG65R580QTF-F	SOT-223	OSG65R580QT

Package & Pin Information



Absolute Maximum Ratings at $T_j=25^{\circ}\text{C}$ unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	650	V
Gate-source voltage	V_{GS}	± 30	V
Continuous drain current ¹⁾ , $T_C=25^{\circ}\text{C}$	I_D	8	A
Continuous drain current ¹⁾ , $T_C=100^{\circ}\text{C}$		5	
Pulsed drain current ²⁾ , $T_C=25^{\circ}\text{C}$	$I_{D, \text{pulse}}$	24	A
Continuous diode forward current ¹⁾ , $T_C=25^{\circ}\text{C}$	I_S	8	A
Diode pulsed current ²⁾ , $T_C=25^{\circ}\text{C}$	$I_{S, \text{pulse}}$	24	A
Power dissipation ³⁾ , $T_C=25^{\circ}\text{C}$	P_D	8	W
Single pulsed avalanche energy ⁵⁾	E_{AS}	90	mJ
MOSFET dv/dt ruggedness, $V_{DS}=0 \dots 480 \text{ V}$	dv/dt	50	V/ns
Reverse diode dv/dt, $V_{DS}=0 \dots 480 \text{ V}$, $I_{SD} \leq I_D$	dv/dt	15	V/ns
Operation and storage temperature	T_{stg}, T_j	-55 to 150	$^{\circ}\text{C}$

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal resistance, junction-case	$R_{\theta JC}$	15.6	$^{\circ}\text{C/W}$
Thermal resistance, junction-ambient ⁴⁾	$R_{\theta JA}$	62	$^{\circ}\text{C/W}$

Electrical Characteristics at $T_j=25^{\circ}\text{C}$ unless otherwise specified

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Drain-source breakdown voltage	BV_{DSS}	650			V	$V_{GS}=0 \text{ V}$, $I_D=250 \mu\text{A}$
Gate threshold voltage	$V_{GS(th)}$	2.9		3.9	V	$V_{DS}=V_{GS}$, $I_D=250 \mu\text{A}$
Drain-source on-state resistance	$R_{DS(on)}$		503	580	m Ω	$V_{GS}=10 \text{ V}$, $I_D=4 \text{ A}$
			1325			$V_{GS}=10 \text{ V}$, $I_D=4 \text{ A}$, $T_j=150^{\circ}\text{C}$
Gate-source leakage current	I_{GSS}			100	nA	$V_{GS}=30 \text{ V}$
				-100		$V_{GS}=-30 \text{ V}$
Drain-source leakage current	I_{DSS}			1	μA	$V_{DS}=650 \text{ V}$, $V_{GS}=0 \text{ V}$
Gate resistance	R_G		48		Ω	$f=1 \text{ MHz}$, Open drain

Dynamic Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Input capacitance	C_{iss}		408		pF	$V_{GS}=0\text{ V}$, $V_{DS}=50\text{ V}$, $f=100\text{ kHz}$
Output capacitance	C_{oss}		47		pF	
Reverse transfer capacitance	C_{rss}		2.8		pF	
Effective output capacitance, energy related	$C_{o(er)}$		25		pF	$V_{GS}=0\text{ V}$, $V_{DS}=0\text{ V-400 V}$
Effective output capacitance, time related	$C_{o(tr)}$		118		pF	
Turn-on delay time	$t_{d(on)}$		13.4		ns	$V_{GS}=10\text{ V}$, $V_{DS}=400\text{ V}$, $R_G=3\ \Omega$, $I_D=4\text{ A}$
Rise time	t_r		15.6		ns	
Turn-off delay time	$t_{d(off)}$		52.4		ns	
Fall time	t_f		17.2		ns	

Gate Charge Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Total gate charge	Q_g		8.9		nC	$V_{GS}=10\text{ V}$, $V_{DS}=400\text{ V}$, $I_D=4\text{ A}$
Gate-source charge	Q_{gs}		2.1		nC	
Gate-drain charge	Q_{gd}		3.5		nC	
Gate plateau voltage	$V_{plateau}$		5.4		V	

Body Diode Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Diode forward voltage	V_{SD}			1.3	V	$I_S=8\text{ A}$, $V_{GS}=0\text{ V}$
Reverse recovery time	t_{rr}		201.6		ns	$V_R=400\text{ V}$, $I_S=4\text{ A}$, $di/dt=100\text{ A}/\mu\text{s}$
Reverse recovery charge	Q_{rr}		1.6		μC	
Peak reverse recovery current	I_{rrm}		15.4		A	

Note

- 1) Calculated continuous current based on maximum allowable junction temperature. Maximum Duty Cycle $D=0.50$; DPAK/IPAK equivalent.
- 2) Repetitive rating; pulse width limited by max. junction temperature.
- 3) P_d is based on max. junction temperature, using junction-case thermal resistance.
- 4) The value of $R_{\theta JA}$ is measured with the device mounted on 1 inch² FR-4 board with 2oz. Copper, in a still air environment with $T_a=25\text{ }^{\circ}\text{C}$.
- 5) $V_{DD}=100\text{ V}$, $V_{GS}=10\text{ V}$, $L=80\text{ mH}$, starting $T_j=25\text{ }^{\circ}\text{C}$.

Electrical Characteristics Diagrams

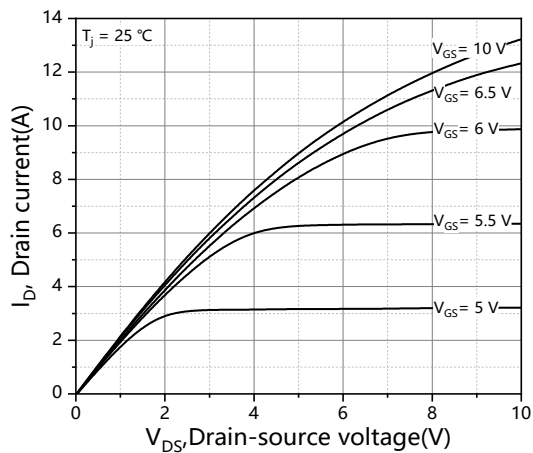


Figure 1. Typ. output characteristics $T_j=25^{\circ}\text{C}$

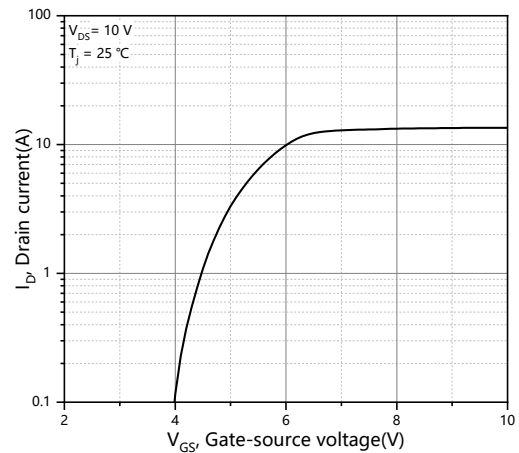


Figure 2. Typ. transfer characteristics

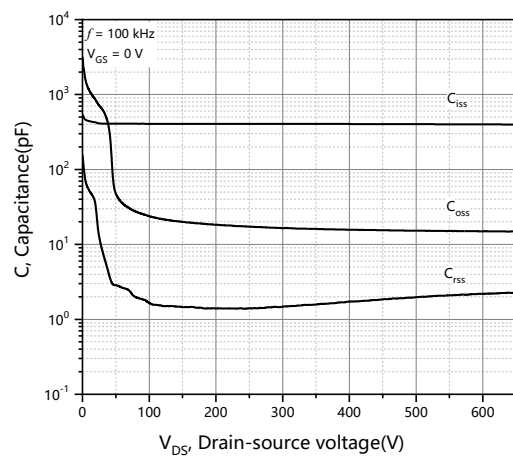


Figure 3. Typ. capacitances

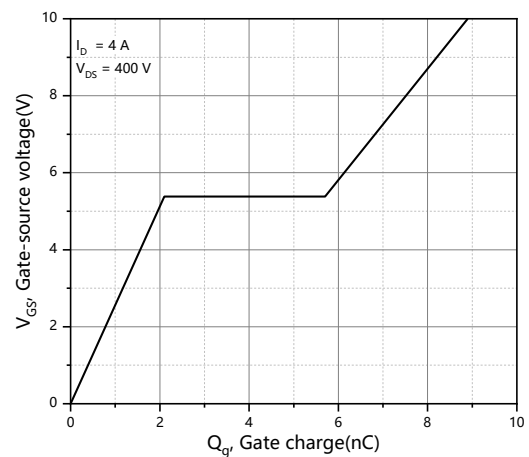


Figure 4. Typ. gate charge

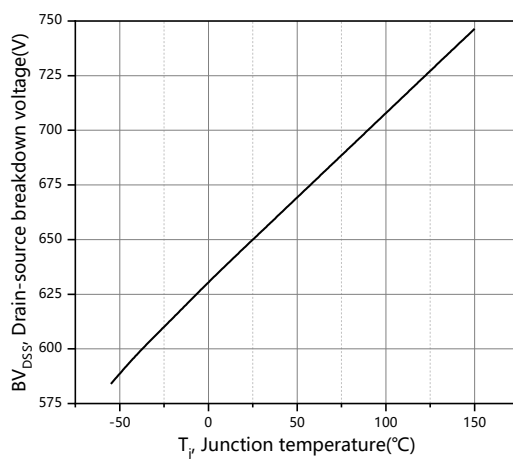


Figure 5. Drain-source breakdown voltage

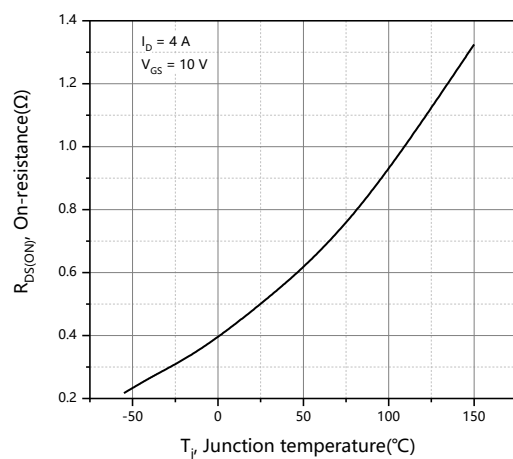


Figure 6. Drain-source on-state resistance

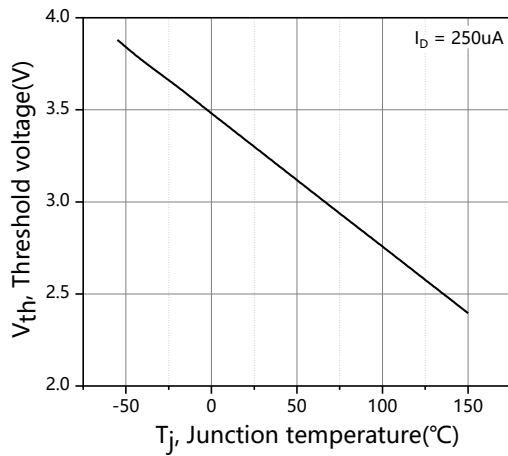


Figure 7. Threshold voltage

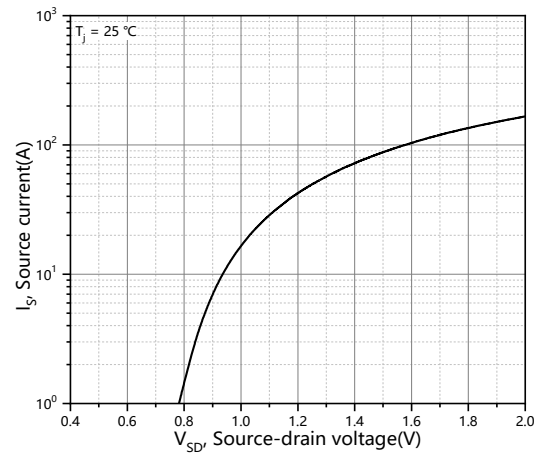


Figure 8. Forward characteristic of body diode

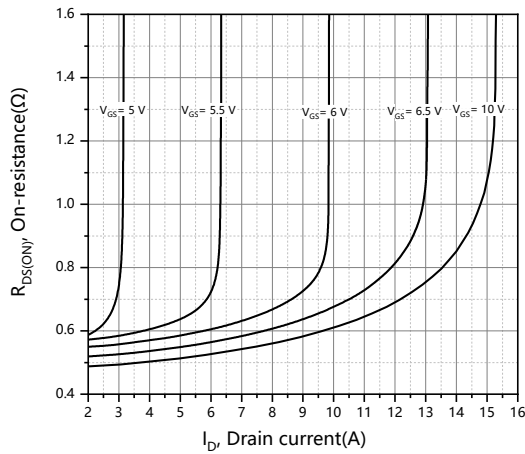


Figure 9. Drain-source on-state resistance

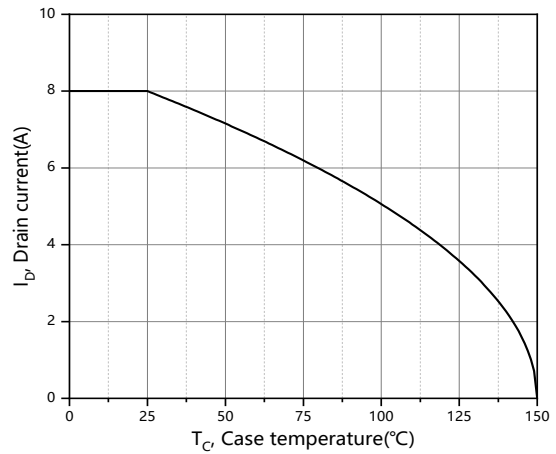


Figure 10. Drain current

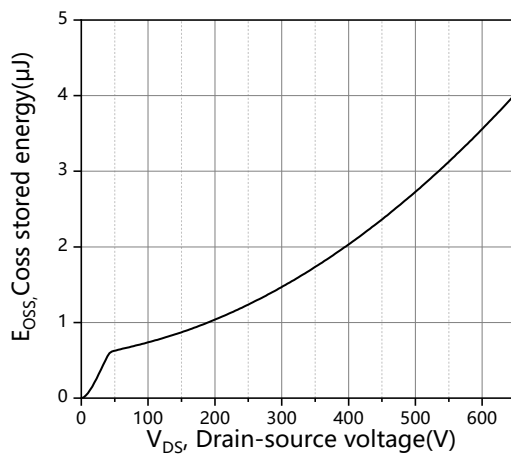


Figure 11. Typ. Coss stored energy

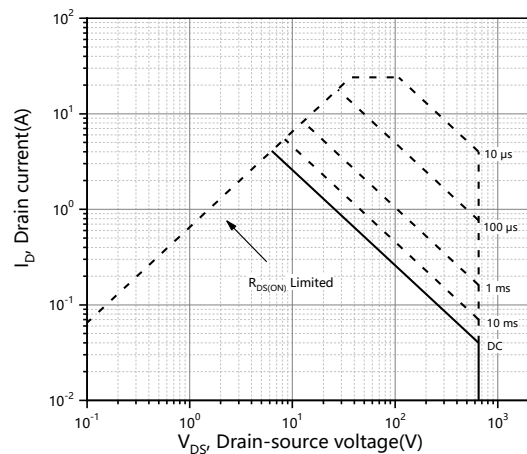


Figure 12. Safe operation area Tc=25°C

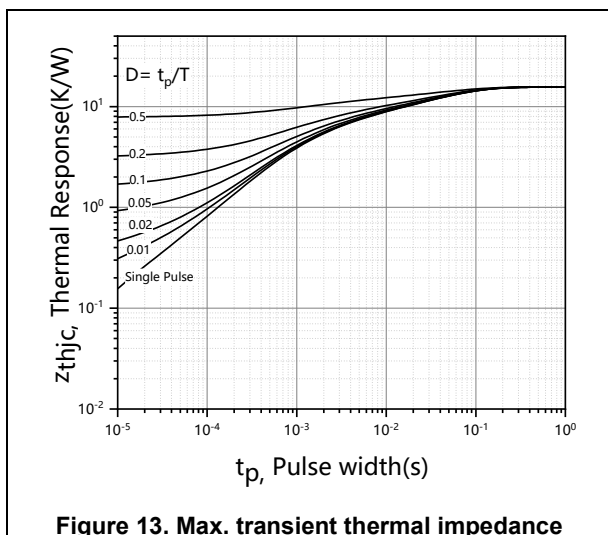


Figure 13. Max. transient thermal impedance

Test circuits and waveforms

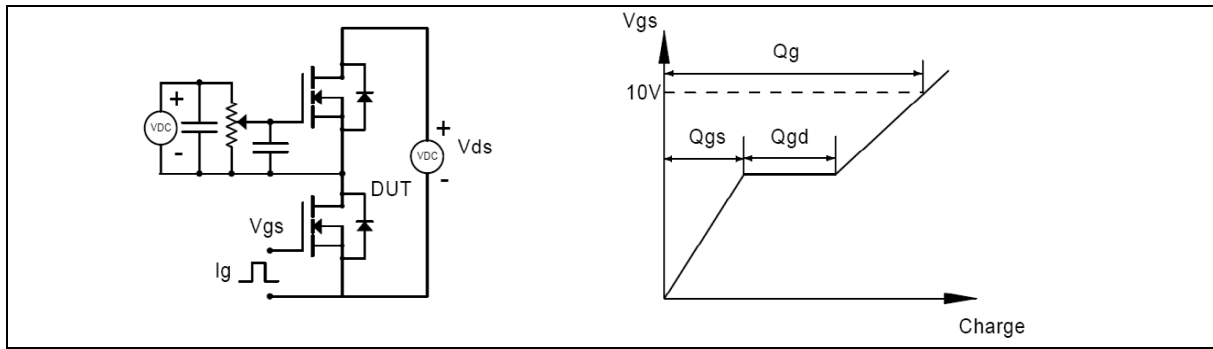


Figure 1. Gate charge test circuit & waveform

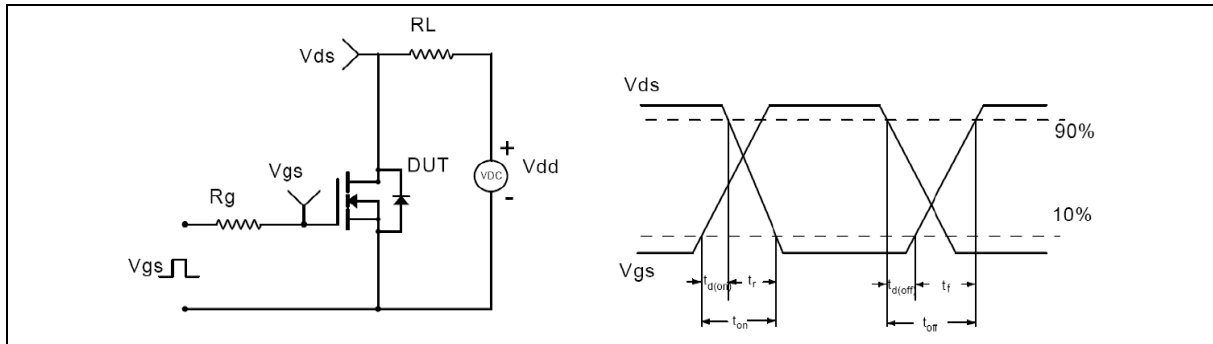


Figure 2. Switching time test circuit & waveforms

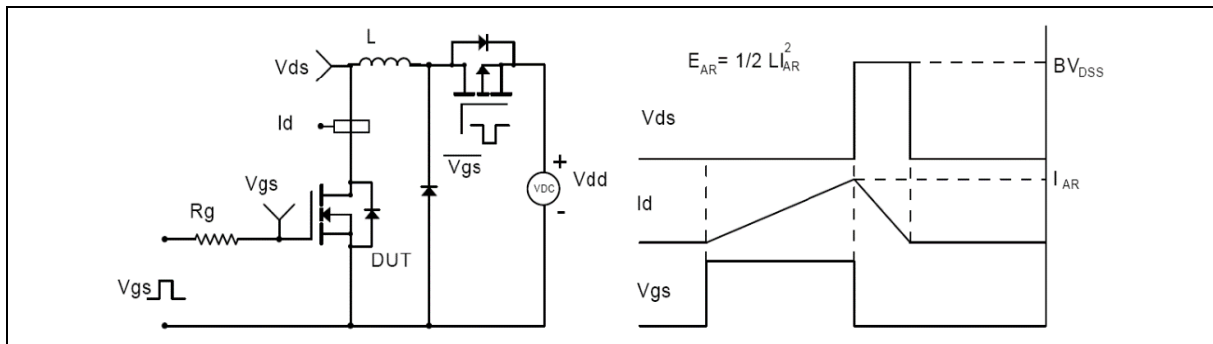


Figure 3. Unclamped inductive switching (UIS) test circuit & waveforms

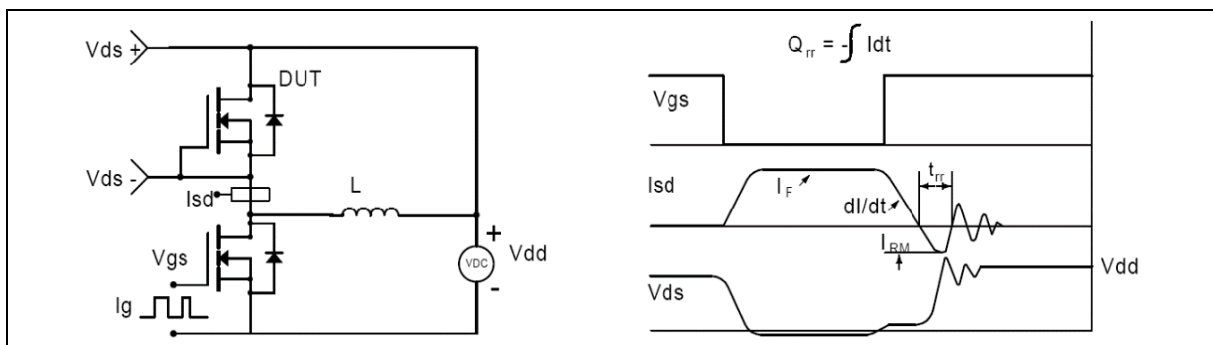
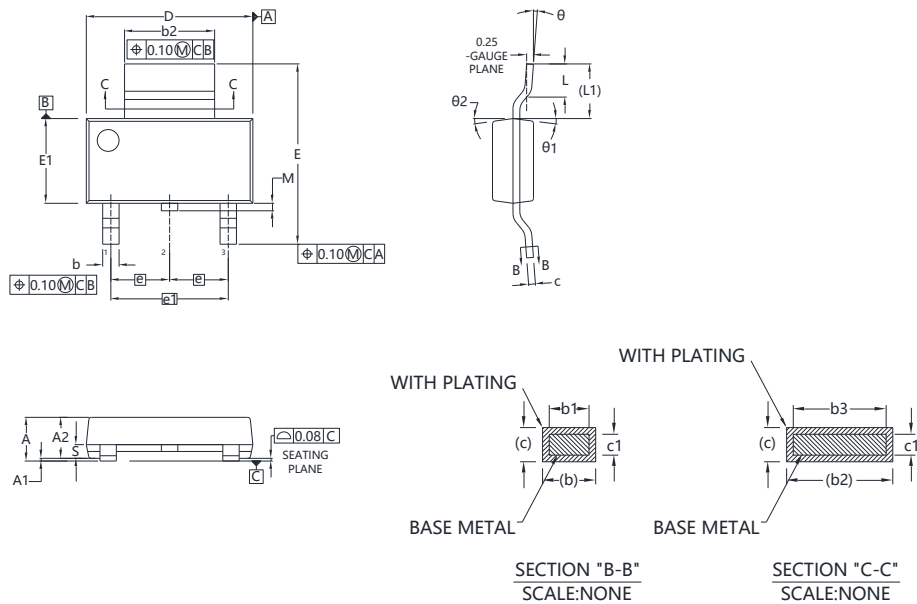


Figure 4. Diode reverse recovery test circuit & waveforms

Package Information



Symbol	mm	
	Min	Max
A	1.52	1.80
A1	0.02	0.10
A2	1.50	1.70
b	0.60	0.80
b1	0.60	0.78
b2	2.95	3.10
b3	2.95	3.05
c	0.24	0.32
c1	0.24	0.30
D	6.30	6.70
E	6.70	7.30
E1	3.30	3.70
e	2.30 BSC	
e1	4.60 BSC	
L	0.90	1.10
L1	1.75 REF	
M	--	0.50
S	0.70 REF	
θ	0°	10°
θ1	10°REF	
θ2	10°REF	

Version 1: SOT-223-S package outline dimension

Product Information

Product	Package	Pb Free	RoHS	Halogen Free
OSG65R580QTF-F	SOT-223	yes	yes	yes

Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Oriental Semiconductor hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

For further information on technology, delivery terms and conditions and prices, please contact the Oriental Semiconductor sales representatives (www.orientalsemi.com).

© Oriental Semiconductor Co.,Ltd. All Rights Reserved 